AiT Semiconductor Inc. www.ait-ic.com

# DESCRIPTION

AM5853 is designed for battery charging controller, • which features P-channel MOSFET characteristics and a 0.12V Schottky diode for reverse current • blocking. Such reverse current blocking feature cut off the current when source voltage is removed, or lower than drain voltage, no matter the gate voltage indicating the P-MOSFET on or off.

AM5853 is also suitable for high side switch in a system with multi power supplies, when isolating different power supplies becomes essential.

AM5853 can block reverse voltage as high as 10V. So it is safe enough for mobile phone system or other portable device powered by 1 cell Li-ion battery.

AM5853 make itself the smallest package available in the world.

The AM5853 is available in DFN6 and SC70-5 packages.

# ORDERING INFORMATION

Package Type	Part Number		
DFN6	J6	AM5853J6R-A	
		AM5853J6VR-A	
		AM5853J6R-B	
		AM5853J6VR-B	
SC70-5	C5	AM5853C5R	
		AM5853C5VR	
Note	V: Halogen free Package		
note	R: Tape & Reel		
AiT provides all RoHS products			
Suffix " V " means Halogen free Package			

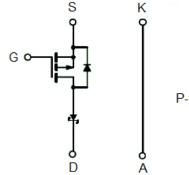
# FEATURES

- PMOSFET with SBD for reverse current blocking
- 0.12V Schottky diode forward voltage
- Range of operation input voltage: Max 12V
- Charging current up to 650mA
- Environment Temperature: -20°C ~85°C
- Available in DFN6 and SC70-5 Packages

## APPLICATION

• Cell phone and other portable device

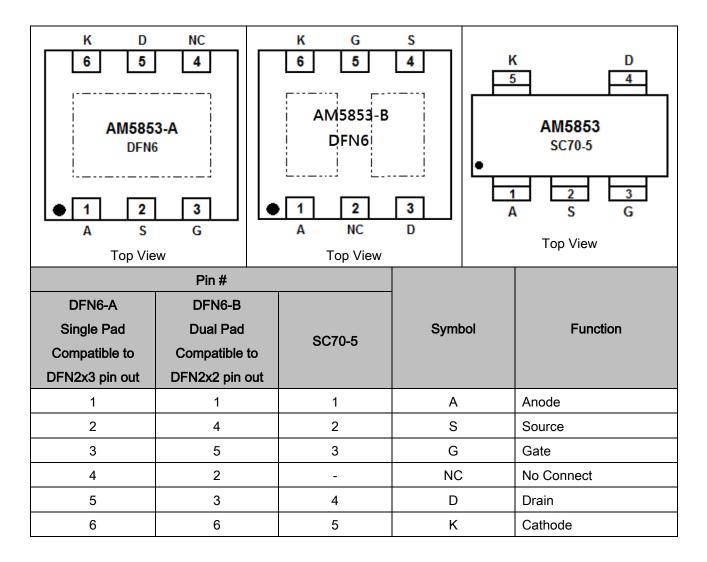
# TYPICAL APPLICATION



P-Channel MOSFET



# **PIN DESCRIPTION**





# ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	5 sec	Steady State	Unit
Forward Voltage(Source-Drain)	$V_{SD}$	12		V
Gate-Source Voltage (MOSFET)	V <sub>GS</sub>	-8~+0.3	-8~+0.3	V
Continuous Drain Current	ID	0.8	0.5	А
Pulsed Drain Current (MOSFET)	Ідм		1	А
Maximum Power Dissipation	PD	2.3	1.4	W
Operating Junction Temperature Range	TJ	−20 t	o 125	
Storage Temperature Range	Tstg	-40 t	o 150	°C
Soldering Recommendations (Peak Temperature)		260°(	C, 10s	

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# THERMAL RESISTANCE RATING

Parameter		Symbol	Device	Тур.	Max	Unit
junction-to-Ambient	t ≤ 5 sec	R <sub>thJA</sub>	DFN6	50	60	°C/W
			SC70-5	250	280	
	Steady State		DFN6	105	120	
			SC70-5	330	400	
Junction to Case Steady State	n	DFN6	20	30	1	
	Steady State	R <sub>thJC</sub>	SC70-5	150	175	



### ELECTRICAL CHARACTERISTICS

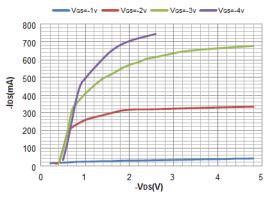
TJ=25°C Parameter Symbol Conditions Min. Тур. Max. Unit V Threshold Voltage  $V_{\text{th}}$  $I_{DS}$ =-10uA,  $V_{DS}$ = $V_{GS}$ -1.0 -0.7 -0.4 Gate-Source Leakage current V<sub>GS</sub>=8V 0 12 20 uA lgs V<sub>GS</sub>=0, Vs=9V, V<sub>D</sub>=0V 0.5 5 PMOS off-state leakage I<sub>DSS</sub>1 uA PMOS reverse block leakage IDSS2 V<sub>G</sub>=0, Vs=0V, V<sub>D</sub>=4.5V 2 10 uA On -state drain current Vs=5V, Vg=1V, VD=4V -650 -500 **D**SON -800 mΑ VDS/IDSON RDSON Vs=5V, Vg=1V, VD=4V 1.25 1.5 2 Ω Forward voltage of schottky VFSBD Vs=4V, V<sub>G</sub>=0V, I<sub>DS</sub>=0 0.08 0.12 0.16 V



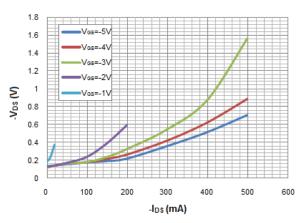
### TYPICAL PERFORMANCE CHARACTERISTICS

#### T=25°C, unless specified

1. Output Characteristics

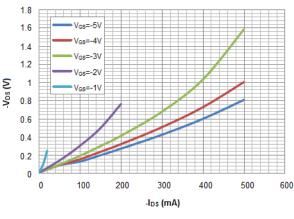


3. Dropout Voltage (V<sub>DS</sub>) Vs. Charge current (I<sub>DS</sub>), T = 25°C

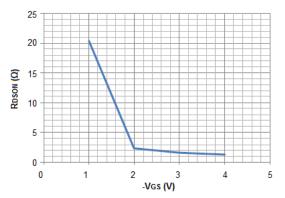


5. Dropout Voltage (V\_DS) Vs. Charge current (I\_DS),  $% \int_{\mathbb{T}} \left( \int_{\mathbb{T}}$ 

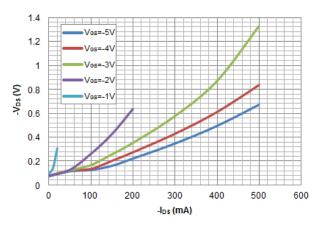
T = 125°C



2. On Resistance Vs V<sub>GS</sub>

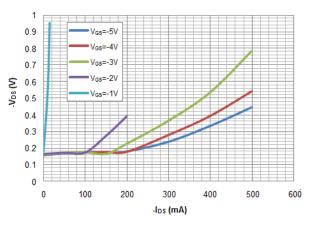


4. Dropout Voltage (V<sub>DS</sub>) Vs. Charge current (I<sub>DS</sub>), T = 80°C

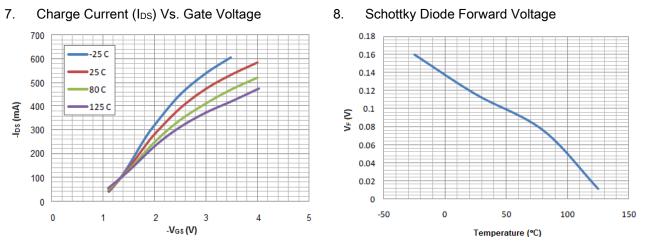


 $6. \quad \ \ Dropout \ Voltage \ (V_{DS}) \ Vs. \ Charge \ current \ (I_{DS}),$ 

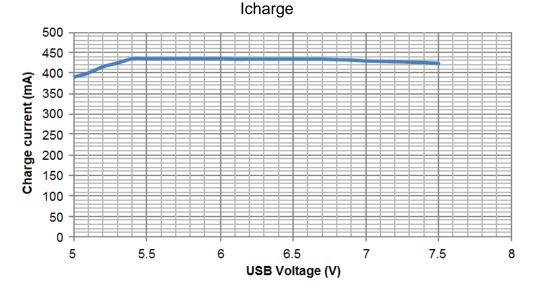
T = -25°C







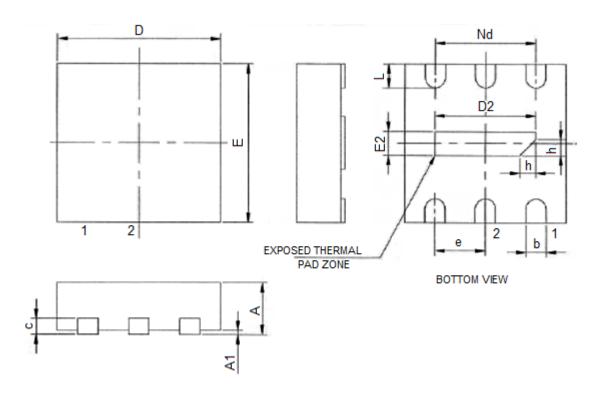
9. Charge current Vs USB voltage tested on actual cell phone powered by MTK chipset





# PACKAGE INFORMATION

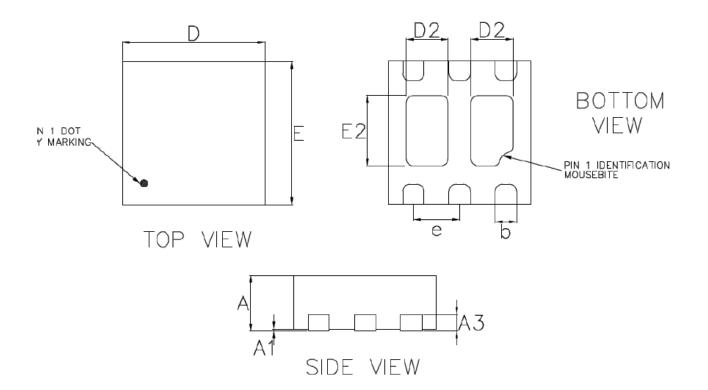
Dimension in DFN6 Single Pad (Unit: mm)



Symbol	Min	Max	
А	0.700	0.800	
A1	-	0.050	
b	0.25	0.35	
с	0.18	0.25	
D	1.95	2.05	
D2	1.00	1.45	
е	0.65BSC		
Nd	1.30BSC		
E	1.95	2.05	
E2	0.20	0.40	
L	0.25	0.40	
h	0.15	0.25	



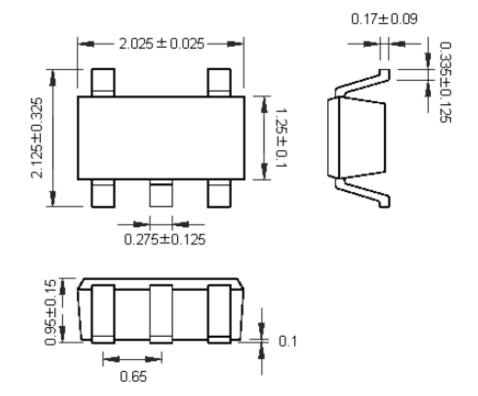
#### Dimension in DFN6 Dual Pad (Unit: mm)



Symbol	Min	Max	
A	0.700	0.800	
A1	0.000	0.050	
A3	0.200 REF.		
D	1.950	2.050	
E	1.950	2.050	
D2	0.440	0.690	
E2	0.840	1.090	
b	0.250	0.350	
L	0.175	0.375	
е	0.650 BSC.		



#### Dimension in SC70-5 (Unit: mm)





#### **IMPORTANT NOTICE**

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